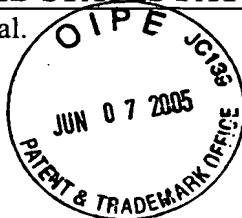


IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IFW

Applicant(s): MAKINO et al.



Atty. Dkt.: 11-231

Serial No.: 10/791,790

Group Art Unit: 2816

Filed: March 4, 2004

Examiner: Unknown

Title: SWITCHED-CAPACITOR LOW-PASS FILTER AND SEMICONDUCTOR PRESSURE SENSOR APPARATUS INCORPORATING THE FILTER

Commissioner for Patents
Alexandria, VA 22314

Date: June 7, 2005

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §1.56, the reference(s) listed on the attached Form PTO-1449 is/are being brought to the attention of the Examiner without any admission that it constitutes statutory prior art, or without any admission that it contains subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

Further, pursuant to 37 C.F.R. §1.97(e), the undersigned hereby certifies that each listed reference(s) was/were first cited in a Communication (copy and translation enclosed) from a foreign patent office in connection with a counterpart foreign application not more than three months prior to the filing of this statement.

Although no fees are believed to be due at this time, it is respectfully requested that any such fees be charged to Deposit Account 50-1147. Also, the Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed references have been considered and made of record.

Respectfully submitted,

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FORM PTO-1449	ATTY. DKT NO. 11-231	SER. NO. 10/791,790
APPLICANT MAKINO et al.		
FILING DATE March 4, 2004	GROUP 2816	



REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
		5,245,344	Sep. 14, 1993	Sooch		

FOREIGN PATENT DOCUMENTS

TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
		JP-A-S63-299406	12/6/88	Japan					X (Abstarct)

* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office)
English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER		DATE CONSIDERED